Notice of References Cited Application/Control No. 10/517,821 Examiner Jie Yang Applicant(s)/Patent Under Reexamination INAZAWA ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	C	US-			
	ם	US-			
	Е	US-			
	F	US-			
	G	US-			
	Ξ	US-			
	ı	US-			
	J	US-	· -		
	Κ	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*	ļ	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U	English translation of DE 3300865						
	٧							
	w							
	х							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.